Application/Control No. Applicant(s)/Patent Under Reexamination TANAKA ET AL. Examiner These C. Physics Applicant(s) Page 1 of 1

2841

U.S. PATENT DOCUMENTS

Thanh S Phan

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
	Α	US-6,256,195	07-2001	Liao	361	685
	В	US-5,943,208	08-1999	Kato et al.	361	685
	C	US-6,005,768	12-1999	Jo	361	685
	D	US-6,283,438	09-2001	Shimada et al.	248	694
	E	US-6,040,980	05-2000	Johnson	361	685
	F	US-6,094,357	07-2000	Deubler et al.	361	782
	G	US-				
	Н	US-				
	1	US-		`		
	j	US-				
	Κ	US-				
	L	US-				
	М	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	○ Classification	
	N	JP-11177261	07-1999	Japan			
	0						:
	Р						
	Q						
	R						
	s						
	Т	-					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	•
	V	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.